

NXH80T120L2Q0S1G

T-Type NPC Power Module

1200 V, 55 A IGBT, 600 V, 50 A IGBT

The NXH80T120L2Q0S1G is a power module containing a T-type neutral point clamped (NPC) three level inverter consisting of two 55 A/1200 V half-bridge IGBTs with 40 A/1200 V half-bridge diodes and two 50 A/600 V NP IGBTs with two 50 A/600 V NP diodes. The module also contains an on-board thermistor.

Features

- T-type NPC Module with 55 A/1200 V and 50 A/600 V IGBTs
- HB IGBT Specifications: $V_{CE(SAT)} = 2.5$ V, $E_{SW} = 1000$ μ J
- NP IGBT Specifications: $V_{CE(SAT)} = 1.5$ V, $E_{SW} = 880$ μ J
- Solder Pins
- Thermistor

Typical Applications

- Solar Inverter
- Uninterruptible Power Supplies

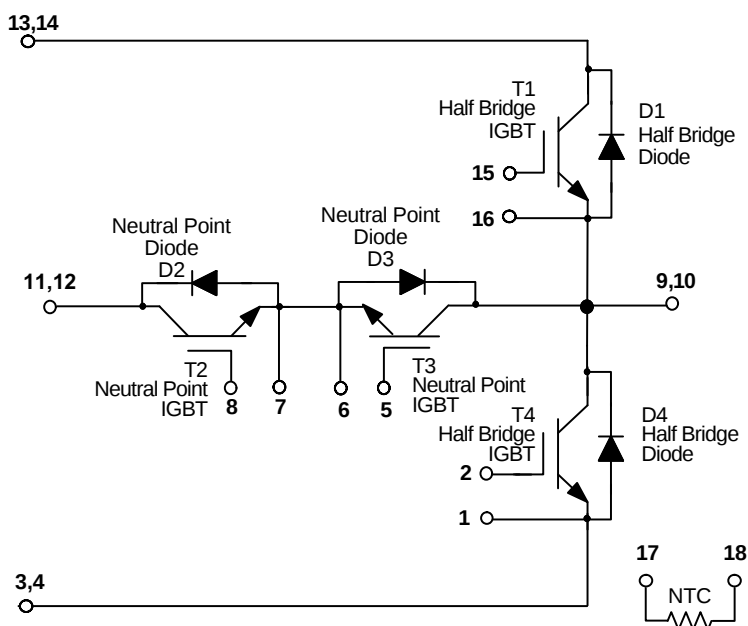
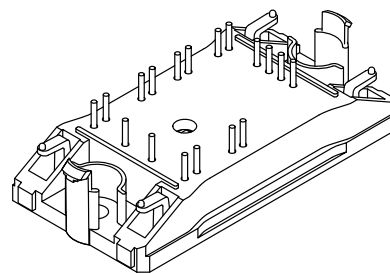


Figure 1. NXH80T120L2Q0S1G Schematic Diagram



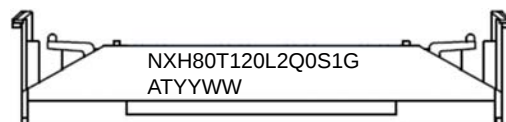
ON Semiconductor®

www.onsemi.com



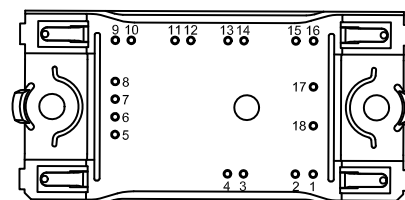
Q0PACK
CASE 180AH

MARKING DIAGRAM



NXH80T120L2Q0S1G = Device Code
YYWW = Year and Work Week Code
A = Assembly Site Code
T = Test Site Code
G = Pb-Free Package

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information in the dimensions section on page 11 of this data sheet.

NXH80T120L2Q0S1G

Table 1. ABSOLUTE MAXIMUM RATINGS (Note 1) $T_J = 25^\circ\text{C}$ unless otherwise noted

Rating	Symbol	Value	Unit
HALF BRIDGE IGBT			
Collector-Emitter Voltage	V_{CES}	1200	V
Gate-Emitter Voltage	V_{GE}	± 20	V
Continuous Collector Current @ $T_h = 80^\circ\text{C}$ ($T_J = 175^\circ\text{C}$)	I_C	57	A
Pulsed Collector Current ($T_J = 175^\circ\text{C}$)	I_{Cpulse}	171	A
Maximum Power Dissipation @ $T_h = 80^\circ\text{C}$ ($T_J = 175^\circ\text{C}$)	P_{tot}	125	W
Short Circuit Withstand Time @ $V_{GE} = 15\text{ V}$, $V_{CE} = 600\text{ V}$, $T_J \leq 150^\circ\text{C}$	T_{sc}	5	μs
Minimum Operating Junction Temperature	T_{JMIN}	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	T_{JMAX}	150	$^\circ\text{C}$
NEUTRAL POINT IGBT			
Collector-Emitter Voltage	V_{CES}	600	V
Gate-Emitter Voltage	V_{GE}	± 20	V
Continuous Collector Current @ $T_h = 80^\circ\text{C}$ ($T_J = 175^\circ\text{C}$)	I_C	52	A
Pulsed Collector Current ($T_J = 175^\circ\text{C}$)	I_{Cpulse}	156	A
Maximum Power Dissipation @ $T_h = 80^\circ\text{C}$ ($T_J = 175^\circ\text{C}$)	P_{tot}	95	W
Short Circuit Withstand Time @ $V_{GE} = 15\text{ V}$, $V_{CE} = 400\text{ V}$, $T_J \leq 150^\circ\text{C}$	T_{sc}	5	μs
Minimum Operating Junction Temperature	T_{JMIN}	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	T_{JMAX}	150	$^\circ\text{C}$
HALF BRIDGE DIODE			
Peak Repetitive Reverse Voltage	V_{RRM}	1200	V
Continuous Forward Current @ $T_h = 80^\circ\text{C}$ ($T_J = 175^\circ\text{C}$)	I_F	25	A
Repetitive Peak Forward Current ($T_J = 175^\circ\text{C}$, t_p limited by T_{Jmax})	I_{FRM}	70	A
Maximum Power Dissipation @ $T_h = 80^\circ\text{C}$ ($T_J = 175^\circ\text{C}$)	P_{tot}	54	W
Minimum Operating Junction Temperature	T_{JMIN}	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	T_{JMAX}	150	$^\circ\text{C}$
NEUTRAL POINT DIODE			
Peak Repetitive Reverse Voltage	V_{RRM}	600	V
Continuous Forward Current @ $T_h = 80^\circ\text{C}$ ($T_J = 175^\circ\text{C}$)	I_F	31	A
Repetitive Peak Forward Current ($T_J = 175^\circ\text{C}$, t_p limited by T_{Jmax})	I_{FRM}	85	A
Maximum Power Dissipation @ $T_h = 80^\circ\text{C}$ ($T_J = 175^\circ\text{C}$)	P_{tot}	53	W
Minimum Operating Junction Temperature	T_{JMIN}	-40	$^\circ\text{C}$
Maximum Operating Junction Temperature	T_{JMAX}	150	$^\circ\text{C}$
THERMAL PROPERTIES			
Storage Temperature range	T_{stg}	-40 to 125	$^\circ\text{C}$
INSULATION PROPERTIES			
Isolation test voltage, $t = 1\text{ sec}$, 60 Hz	V_{is}	3000	V_{RMS}
Creepage distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

Table 2. RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	T_J	-40	($T_{Jmax} - 25$)	$^\circ\text{C}$

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

NXH80T120L2Q0S1G

Table 3. ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
HALF BRIDGE IGBT CHARACTERISTICS						
Collector–Emitter Cutoff Current	$V_{GE} = 0\text{ V}, V_{CE} = 1200\text{ V}$	I_{CES}	–	–	300	μA
Collector–Emitter Saturation Voltage	$V_{GE} = 15\text{ V}, I_C = 80\text{ A}, T_J = 25^\circ\text{C}$	$V_{CE(sat)}$	–	2.50	2.85	V
	$V_{GE} = 15\text{ V}, I_C = 80\text{ A}, T_J = 150^\circ\text{C}$		–	2.15	–	
Gate–Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1.5\text{ mA}$	$V_{GE(TH)}$	–	5.45	6.4	V
Gate Leakage Current	$V_{GE} = 20\text{ V}, V_{CE} = 0\text{ V}$	I_{GES}	–	–	300	nA
Turn–on Delay Time	$T_J = 25^\circ\text{C}$ $V_{CE} = 350\text{ V}, I_C = 40\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 4\ \Omega$	$t_{d(on)}$	–	37	–	ns
Rise Time		t_r	–	23	–	
Turn–off Delay Time		$t_{d(off)}$	–	190	–	
Fall Time		t_f	–	30	–	
Turn–on Switching Loss per Pulse		E_{on}	–	320	–	μJ
Turn–off Switching Loss per Pulse		E_{off}	–	680	–	
Turn–on Delay Time	$T_J = 125^\circ\text{C}$ $V_{CE} = 350\text{ V}, I_C = 40\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 4\ \Omega$	$t_{d(on)}$	–	30	–	ns
Rise Time		t_r	–	25	–	
Turn–off Delay Time		$t_{d(off)}$	–	230	–	
Fall Time		t_f	–	90	–	
Turn–on Switching Loss per Pulse		E_{on}	–	500	–	μJ
Turn–off Switching Loss per Pulse		E_{off}	–	1300	–	
Input Capacitance	$V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 10\text{ kHz}$	C_{ies}	–	19400	–	pF
Output Capacitance		C_{oes}	–	400	–	
Reverse Transfer Capacitance		C_{res}	–	340	–	
Total Gate Charge	$V_{CE} = 600\text{ V}, I_C = 80\text{ A}, V_{GE} = 15\text{ V}$	Q_g	–	800	–	nC
Thermal Resistance – chip–to–heatsink	Thermal grease, Thickness = 100 μm , $\lambda = 0.84\text{ W/mK}$	R_{thJH}	–	0.76	–	$^\circ\text{C/W}$

NEUTRAL POINT DIODE CHARACTERISTICS

Diode Forward Voltage	$I_F = 50\text{ A}, T_J = 25^\circ\text{C}$	V_F	–	2.60	2.85	V
	$I_F = 50\text{ A}, T_J = 150^\circ\text{C}$		–	2.0	–	
Reverse Recovery Time	$T_J = 25^\circ\text{C}$ $V_{CE} = 350\text{ V}, I_C = 40\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 4\ \Omega$	t_{rr}	–	30	–	ns
Reverse Recovery Charge		Q_{rr}	–	305	–	μC
Peak Reverse Recovery Current		I_{RRM}	–	22	–	A
Peak Rate of Fall of Recovery Current		di/dt	–	1870	–	A/ μs
Reverse Recovery Energy		E_{rr}	–	77	–	μJ
Reverse Recovery Time	$T_J = 125^\circ\text{C}$ $V_{CE} = 350\text{ V}, I_C = 40\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 4\ \Omega$	t_{rr}	–	34	–	ns
Reverse Recovery Charge		Q_{rr}	–	910	–	nC
Peak Reverse Recovery Current		I_{RRM}	–	50	–	A
Peak Rate of Fall of Recovery Current		di/dt	–	4200	–	A/ μs
Reverse Recovery Energy		E_{rr}	–	200	–	μJ
Thermal Resistance – chip–to–heatsink	Thermal grease, Thickness = 100 μm , $\lambda = 0.84\text{ W/mK}$	R_{thJH}	–	1.80	–	$^\circ\text{C/W}$

NEUTRAL POINT IGBT CHARACTERISTICS

Collector–Emitter Cutoff Current	$V_{GE} = 0\text{ V}, V_{CE} = 600\text{ V}$	I_{CES}	–	–	200	μA
Collector–Emitter Saturation Voltage	$V_{GE} = 15\text{ V}, I_C = 50\text{ A}, T_J = 25^\circ\text{C}$	$V_{CE(sat)}$	–	1.50	1.75	V
	$V_{GE} = 15\text{ V}, I_C = 50\text{ A}, T_J = 150^\circ\text{C}$		–	1.60	–	
Gate–Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1.2\text{ mA}$	$V_{GE(TH)}$	–	5.45	6.4	V
Gate Leakage Current	$V_{GE} = 20\text{ V}, V_{CE} = 0\text{ V}$	I_{GES}	–	–	200	nA

NXH80T120L2Q0S1G

Table 3. ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
NEUTRAL POINT IGBT CHARACTERISTICS						
Turn-on Delay Time	$T_J = 25^\circ\text{C}$ $V_{CE} = 350\text{ V}, I_C = 40\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 4\ \Omega$	$t_{d(on)}$	—	23	—	ns
Rise Time		t_r	—	17	—	
Turn-off Delay Time		$t_{d(off)}$	—	108	—	
Fall Time		t_f	—	31	—	
Turn-on Switching Loss per Pulse		E_{on}	—	360	—	μJ
Turn-off Switching Loss per Pulse		E_{off}	—	520	—	
Turn-on Delay Time	$T_J = 125^\circ\text{C}$ $V_{CE} = 350\text{ V}, I_C = 40\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 4\ \Omega$	$t_{d(on)}$	—	27	—	ns
Rise Time		t_r	—	17	—	
Turn-off Delay Time		$t_{d(off)}$	—	130	—	
Fall Time		t_f	—	75	—	
Turn-on Switching Loss per Pulse		E_{on}	—	535	—	μJ
Turn-off Switching Loss per Pulse		E_{off}	—	865	—	
Input Capacitance	$V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 10\text{ kHz}$	C_{ies}	—	9400	—	pF
Output Capacitance		C_{oes}	—	280	—	
Reverse Transfer Capacitance		C_{res}	—	250	—	
Total Gate Charge	$V_{CE} = 480\text{ V}, I_C = 50\text{ A}, V_{GE} = 15\text{ V}$	Q_g	—	395	—	nC
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness < 100 μm , $\lambda = 0.84\text{ W/mK}$	R_{thJH}	—	1.00	—	$^\circ\text{C/W}$

HALF BRIDGE DIODE CHARACTERISTICS

Diode Forward Voltage	$I_F = 40\text{ A}, T_J = 25^\circ\text{C}$	V_F	—	2.65	3.45	V
	$I_F = 40\text{ A}, T_J = 150^\circ\text{C}$		—	2.15	—	
Reverse Recovery Time	$T_J = 25^\circ\text{C}$ $V_{CE} = 350\text{ V}, I_C = 40\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 4\ \Omega$	t_{rr}	—	38	—	ns
Reverse Recovery Charge		Q_{rr}	—	853	—	nC
Peak Reverse Recovery Current		I_{RRM}	—	43	—	A
Peak Rate of Fall of Recovery Current		di/dt	—	2600	—	A/ μs
Reverse Recovery Energy		E_{rr}	—	200	—	μJ
Reverse Recovery Time	$T_J = 125^\circ\text{C}$ $V_{CE} = 350\text{ V}, I_C = 40\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 4\ \Omega$	t_{rr}	—	300	—	ns
Reverse Recovery Charge		Q_{rr}	—	2550	—	nC
Peak Reverse Recovery Current		I_{RRM}	—	57	—	A
Peak Rate of Fall of Recovery Current		di/dt	—	2340	—	A/ μs
Reverse Recovery Energy		E_{rr}	—	390	—	μJ
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness < 100 μm , $\lambda = 0.84\text{ W/mK}$	R_{thJH}	—	1.76	—	$^\circ\text{C/W}$

THERMISTOR CHARACTERISTICS

Nominal resistance		R_{25}	—	22	—	k Ω
Nominal resistance	$T = 100^\circ\text{C}$	R_{100}	—	1486	—	Ω
Deviation of R25		$\Delta R/R$	–5		5	%
Power dissipation		P_D	—	200	—	mW
Power dissipation constant			—	2	—	mW/K
B-value	B(25/50), tolerance $\pm 3\%$		—	3950	—	K
B-value	B(25/100), tolerance $\pm 3\%$		—	3998	—	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS – Half Bridge IGBT and Neutral Point Diode

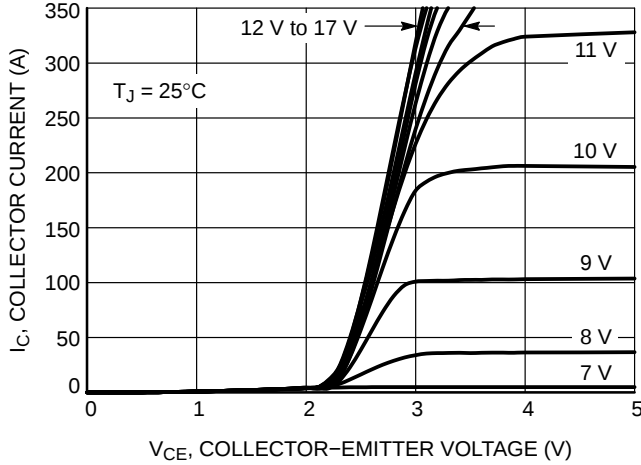


Figure 1. IGBT Typical Output Characteristics

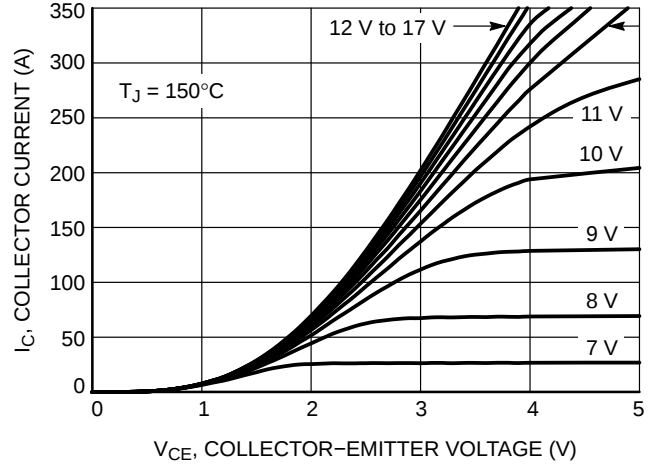


Figure 2. IGBT Typical Output Characteristics

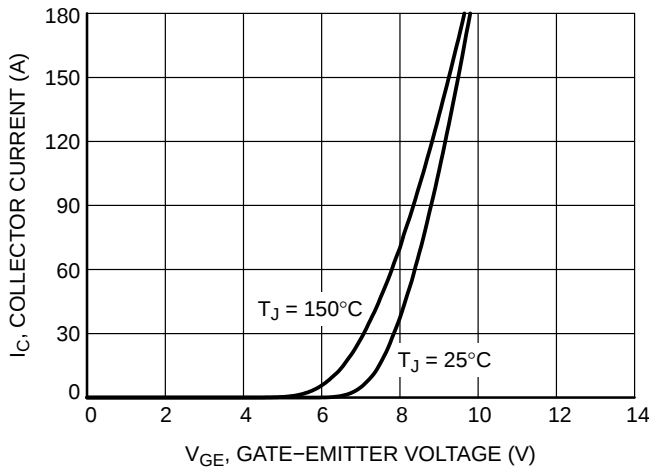


Figure 3. IGBT Typical Transfer Characteristics

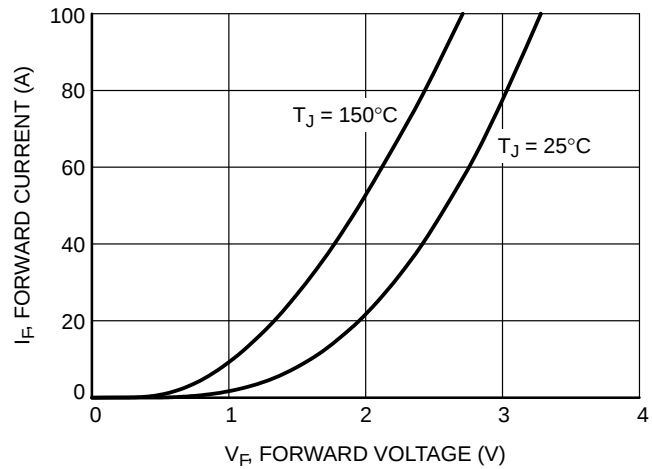


Figure 4. Diode Forward Characteristics

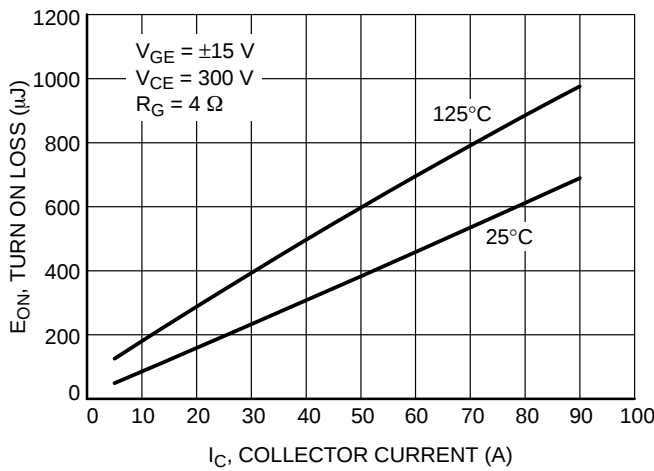


Figure 5. Typical Turn On Loss vs. IC

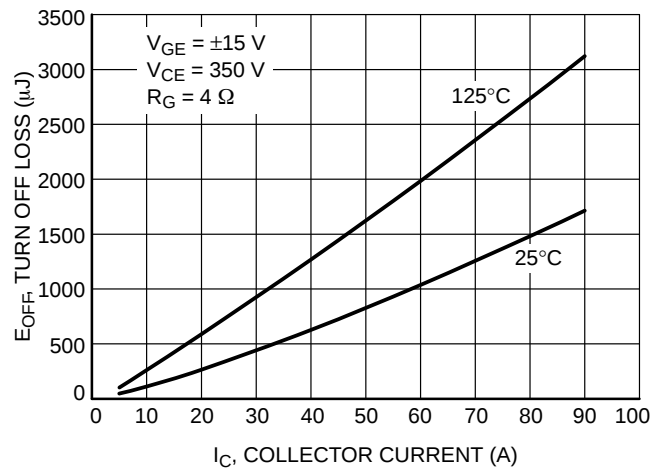


Figure 6. Typical Turn Off Loss vs. IC

NXH80T120L2Q0S1G

TYPICAL CHARACTERISTICS – Half Bridge IGBT and Neutral Point Diode

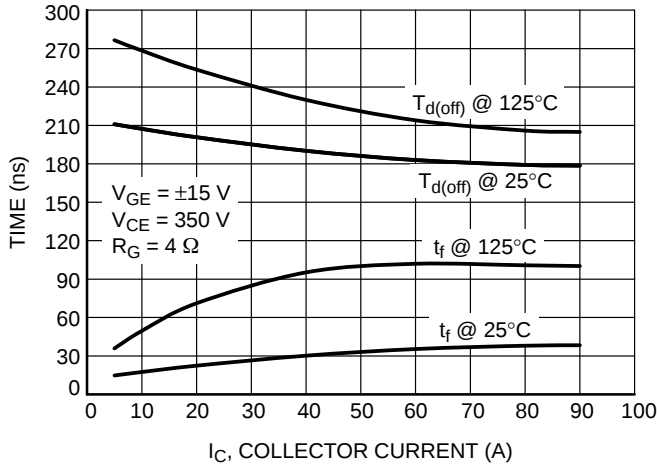


Figure 7. Typical Switching Times vs. I_C

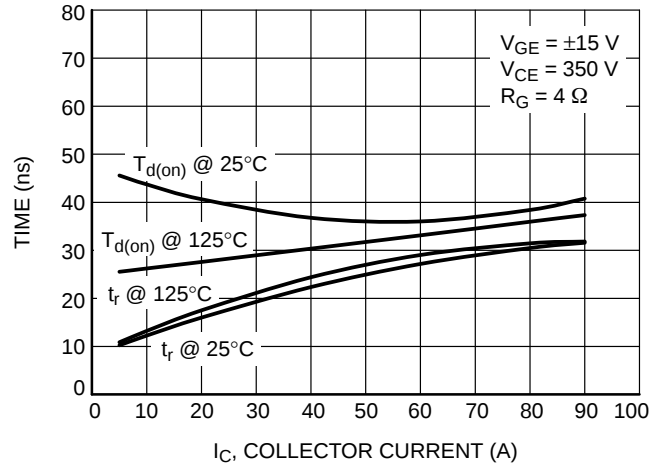


Figure 8. Typical Switching Times vs. I_C

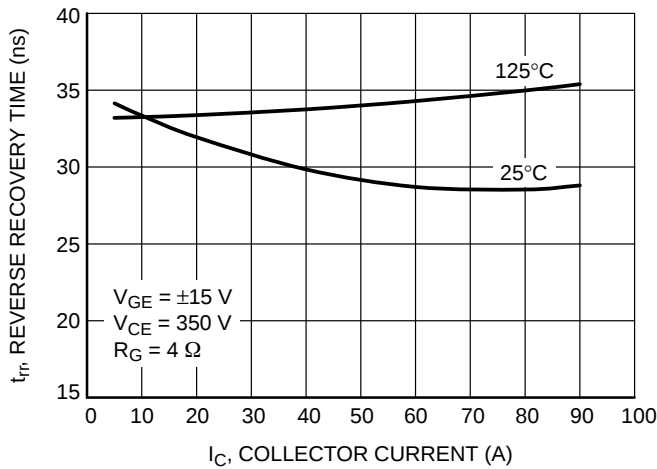


Figure 9. Typical Reverse Recovery Time vs. I_C

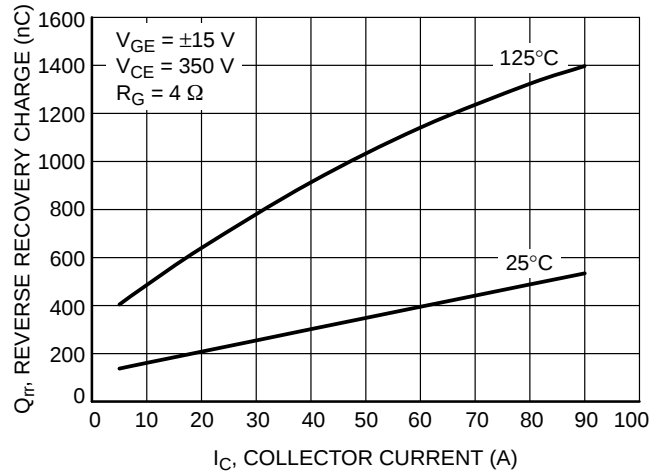


Figure 10. Typical Reverse Recovery Charge vs. I_C

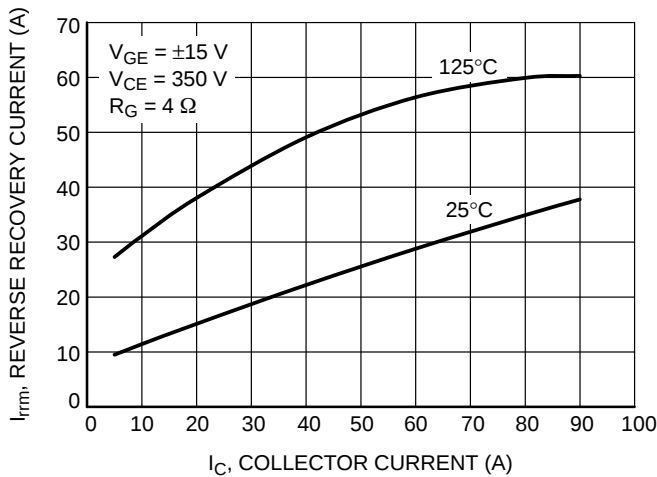


Figure 11. Typical Reverse Recovery Peak Current vs. I_C

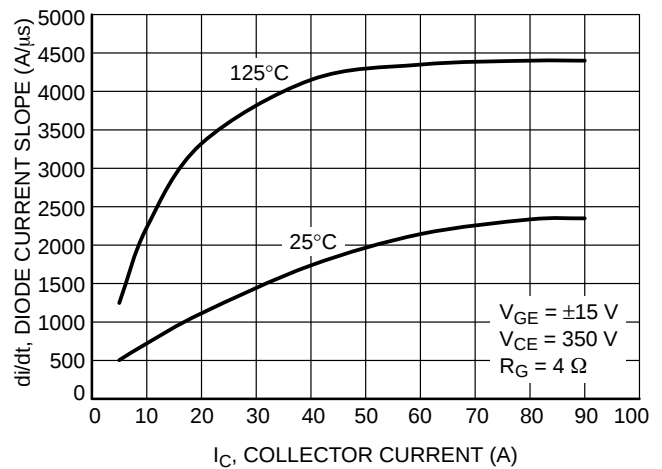


Figure 12. Typical Diode Current Slope vs. I_C

NXH80T120L2Q0S1G

TYPICAL CHARACTERISTICS – Half Bridge IGBT and Neutral Point Diode

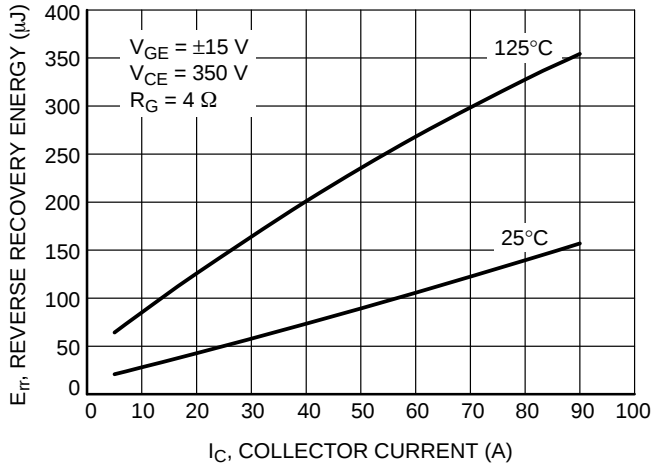


Figure 13. Typical Reverse Recovery Time vs. I_C

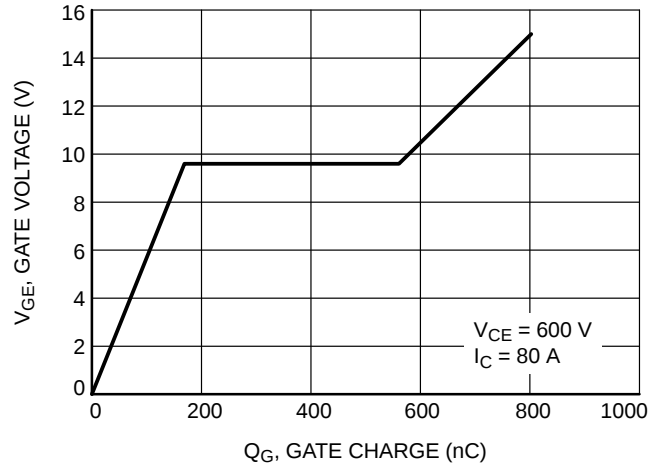


Figure 14. Gate Voltage vs. Gate Charge

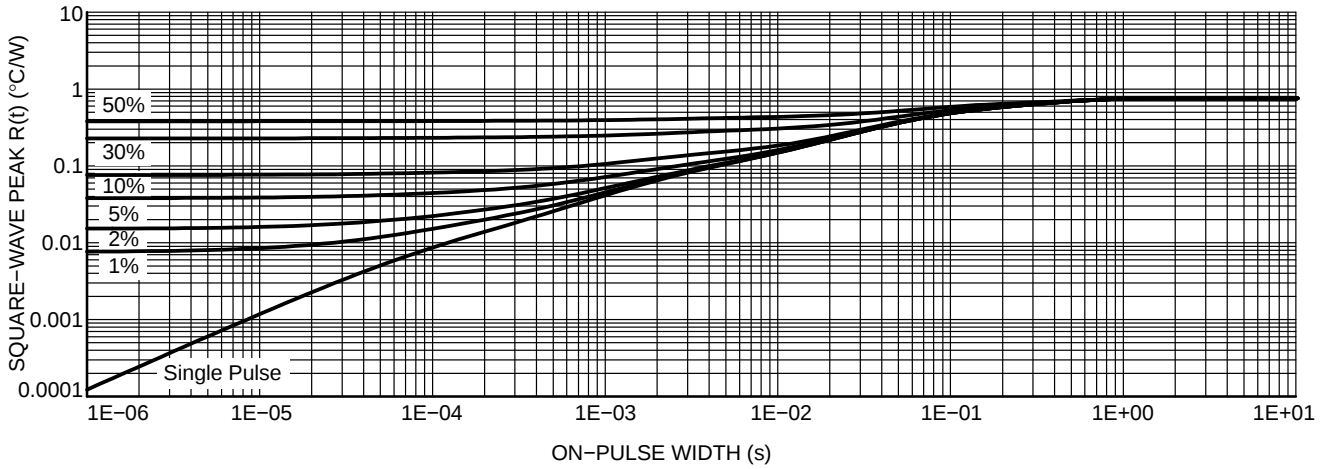


Figure 15. IGBT Transient Thermal Impedance

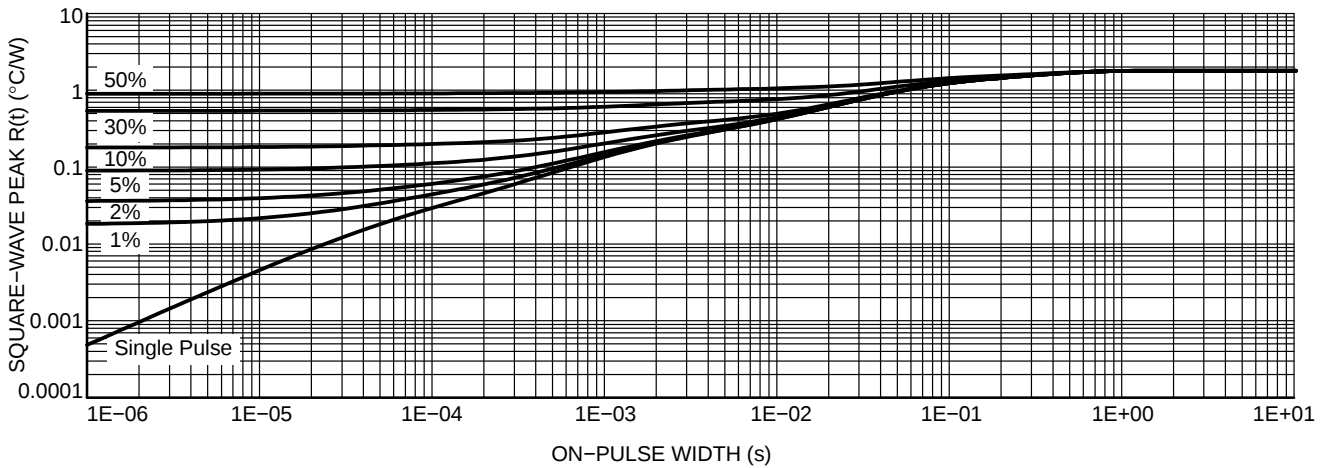


Figure 16. Diode Transient Thermal Impedance

TYPICAL CHARACTERISTICS – Neutral Point IGBT and Half Bridge Diode

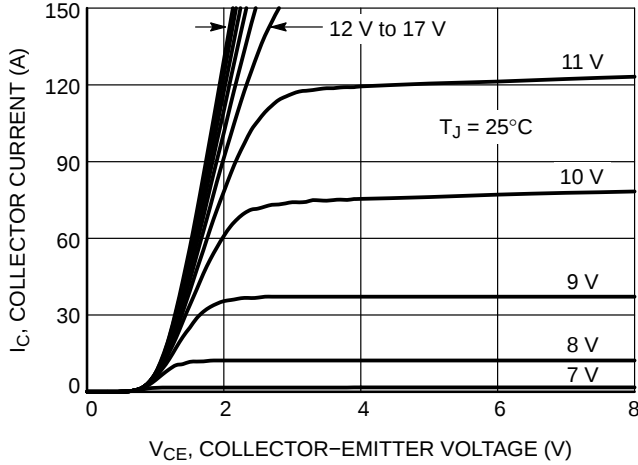


Figure 17. IGBT Typical Output Characteristics

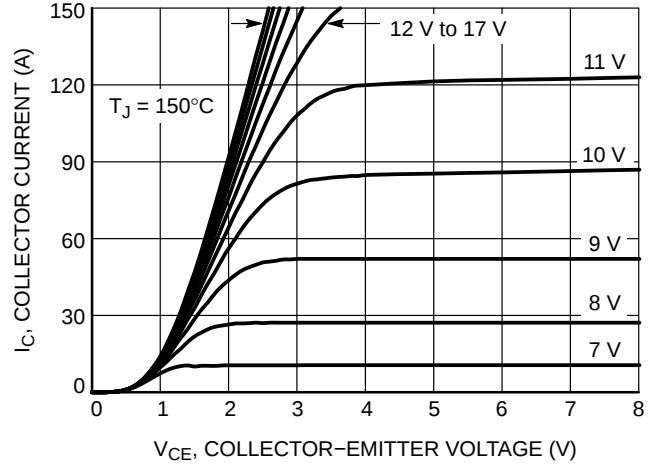


Figure 18. IGBT Typical Output Characteristics

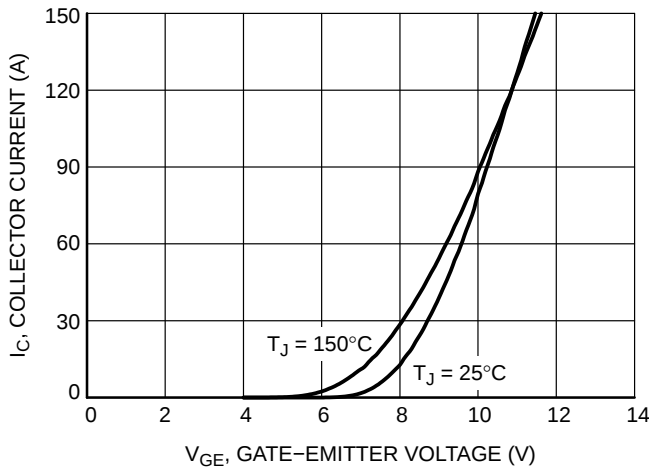


Figure 19. IGBT Typical Transfer Characteristics

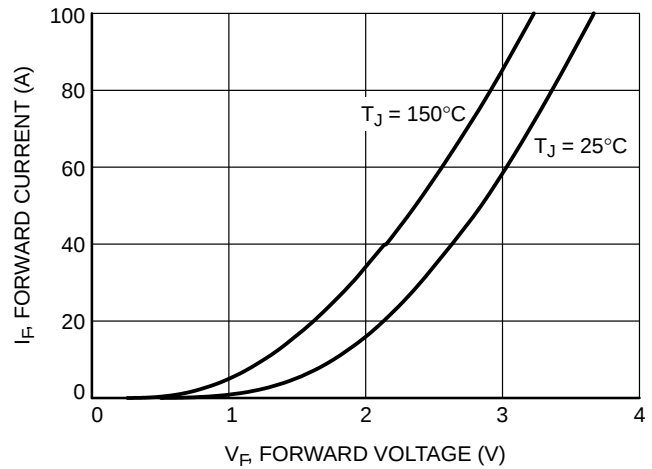


Figure 20. Diode Forward Characteristic

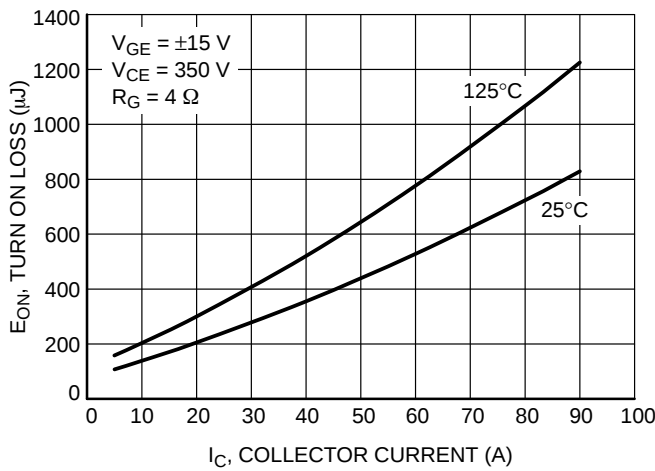


Figure 21. Typical Turn On Loss vs. I_C

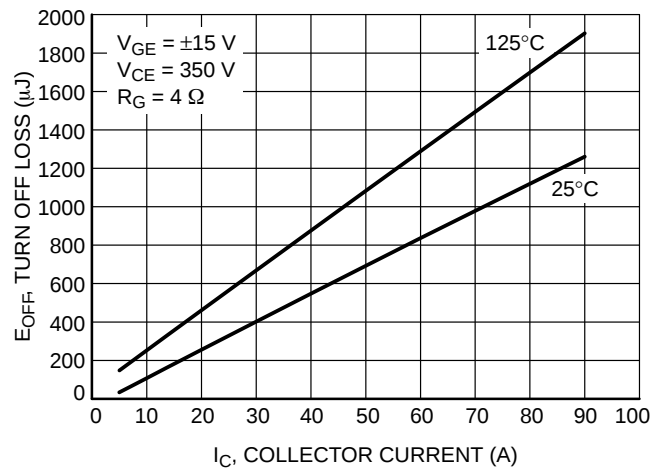


Figure 22. Typical Turn Off Loss vs. I_C

NXH80T120L2Q0S1G

TYPICAL CHARACTERISTICS – Neutral Point IGBT and Half Bridge Diode

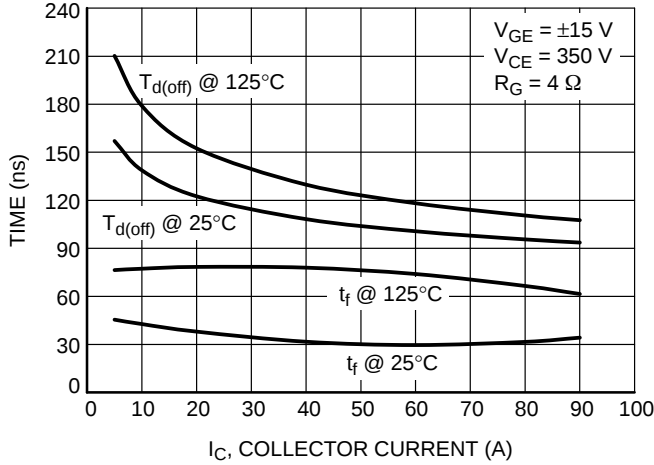


Figure 23. Typical Switching Times vs. IC

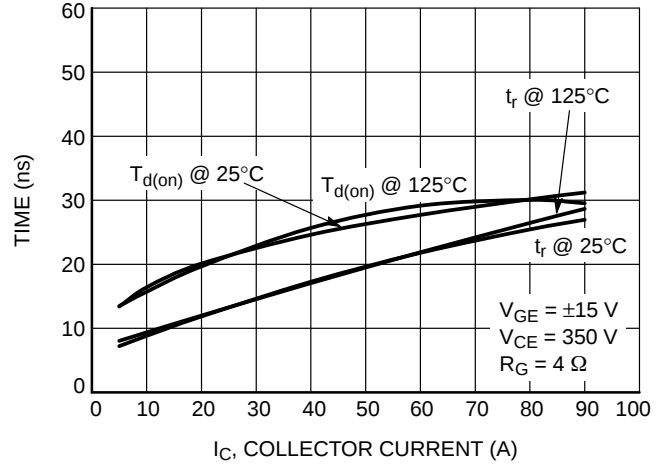


Figure 24. Typical Switching Times vs. IC

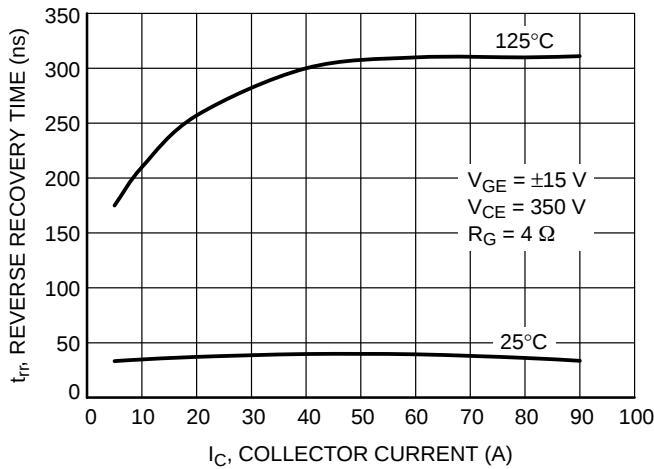


Figure 25. Typical Reverse Recovery Time vs. IC

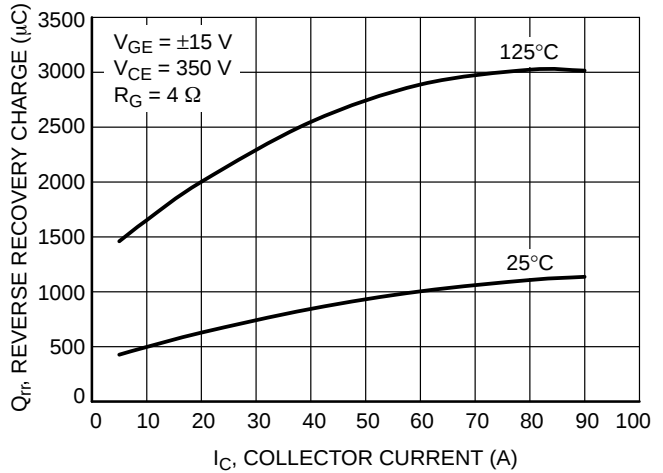


Figure 26. Typical Reverse Recovery Charge vs. IC

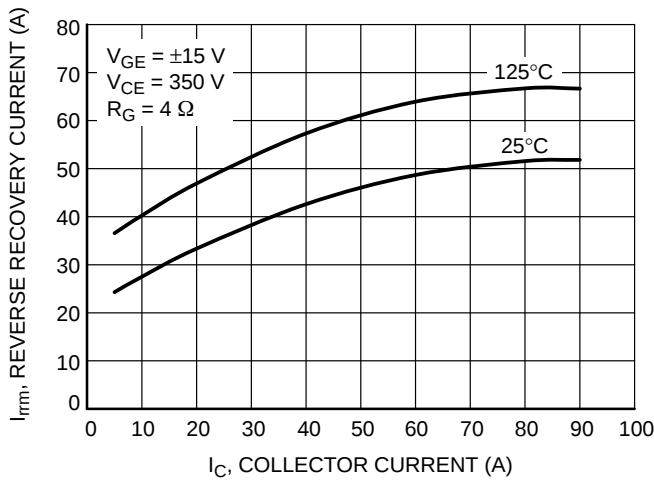


Figure 27. Typical Reverse Recovery Peak Current vs. IC

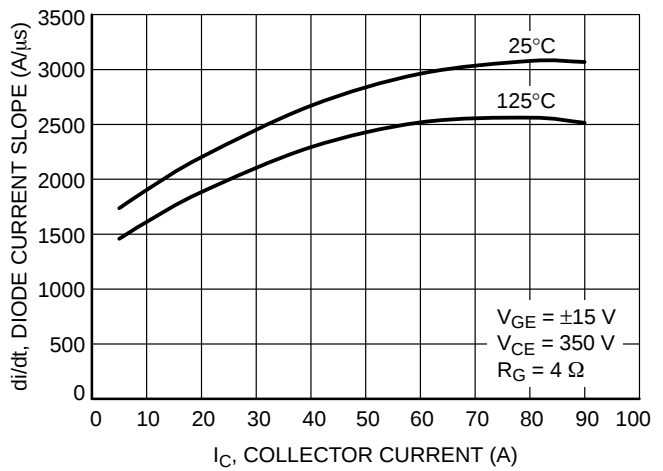


Figure 28. Typical Diode Current Slope vs. IC

NXH80T120L2Q0S1G

TYPICAL CHARACTERISTICS – Neutral Point IGBT and Half Bridge Diode

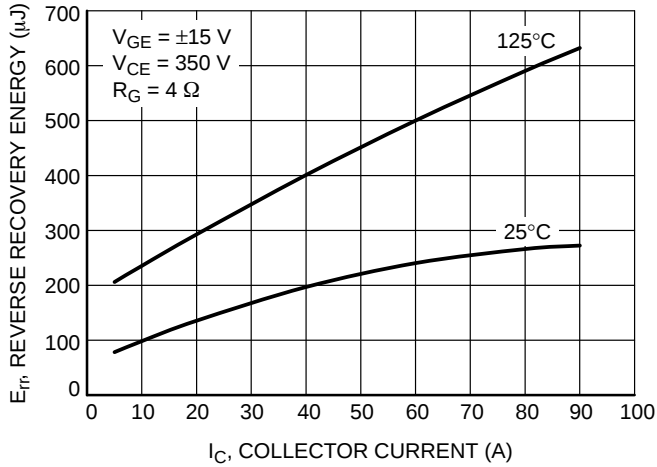


Figure 29. Typical Reverse Recovery Energy vs. I_C

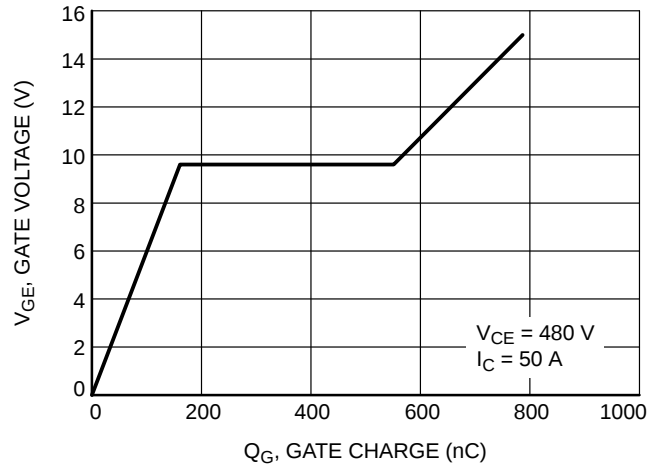


Figure 30. Gate Voltage vs. Gate Charge

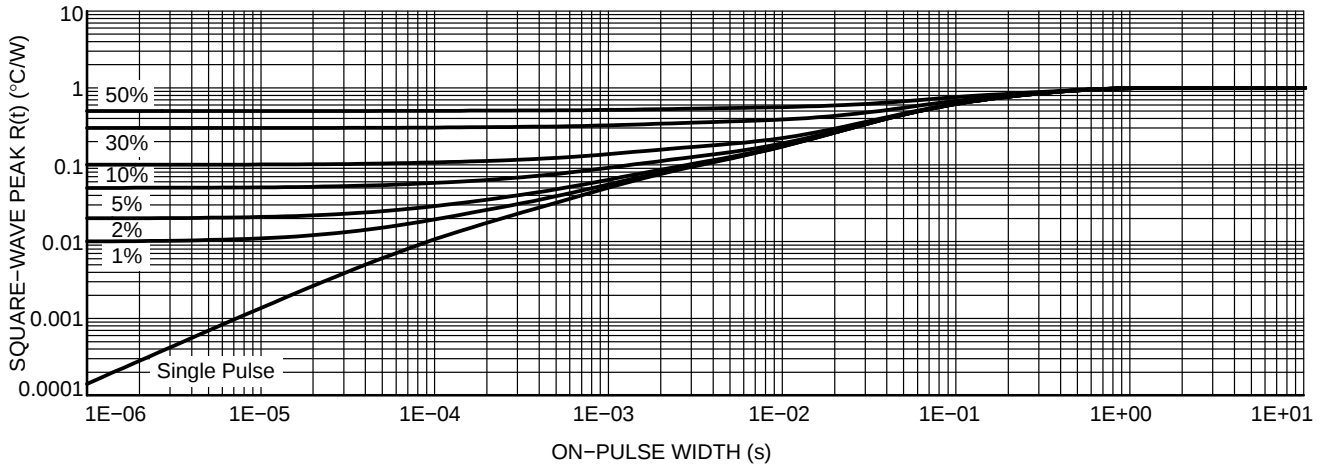


Figure 31. IGBT Transient Thermal Impedance

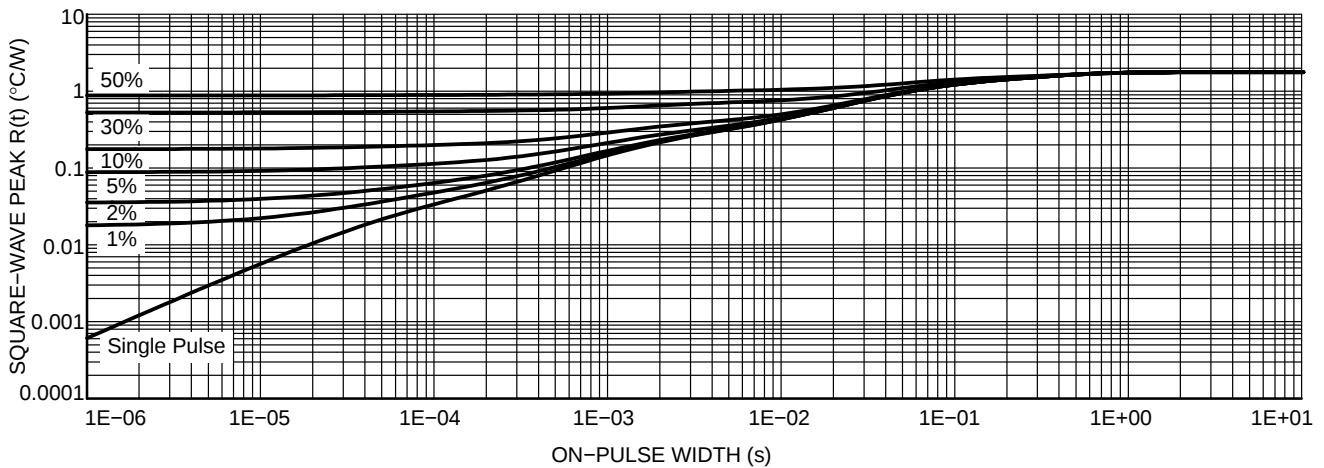


Figure 32. Diode Transient Thermal Impedance

NXH80T120L2Q0S1G

TYPICAL CHARACTERISTICS – Thermistor

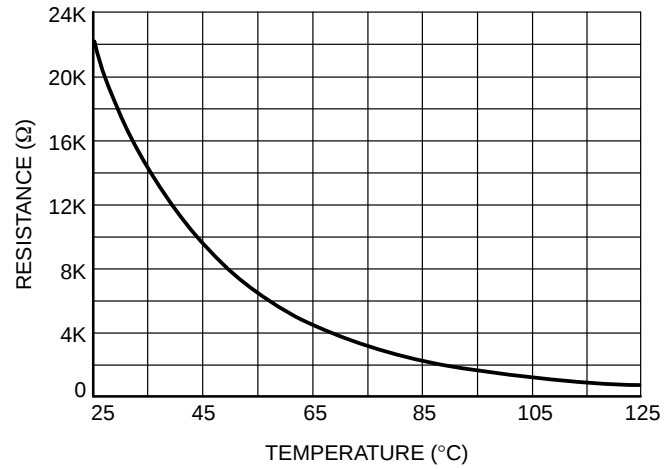


Figure 33. Thermistor Characteristics

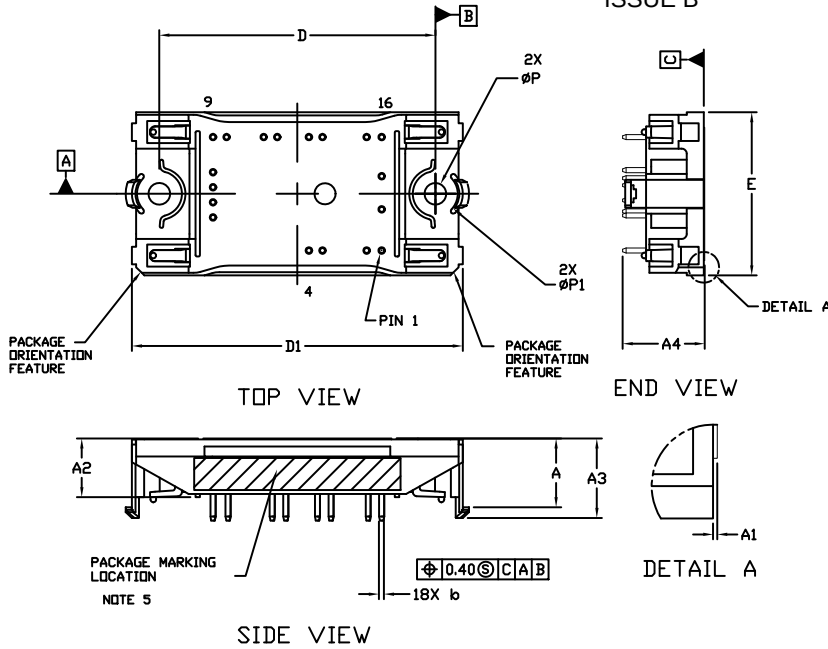
ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH80T120L2Q0S1G Q0PACK	NXH80T120L2Q0S1G	Q0PACK – Case 180AH (Pb-Free and Halide-Free)	24 Units / Blister Tray

NXH80T120L2Q0S1G

PACKAGE DIMENSIONS

PIM18, 55x32.5 / Q0PACK
CASE 180AH
ISSUE B



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSION b APPLIES TO THE PLATED TERMINALS AND IS MEASURED BETWEEN 1.00 AND 3.00 FROM THE TERMINAL TIP.
4. POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH DIRECTIONS.
5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

DIM	MILLIMETERS	
	MIN.	NDM.
A	13.50	13.90
A1	0.10	0.30
A2	11.50	11.90
A3	15.65	16.05
A4	16.35	REF
b	0.95	1.05
D	54.80	55.20
D1	65.60	66.20
E	32.20	32.80
P	4.20	4.40
P1	8.90	9.10

MOUNTING HOLE POSITION

NOTE 4

PIN	PIN POSITION		PIN	PIN POSITION		PIN	PIN POSITION		PIN	PIN POSITION	
	X	Y		X	Y		X	Y		X	Y
1	16.80	11.30	10	-14.10	-10.70	1	16.80	-11.30	10	-14.10	10.70
2	13.80	11.30	11	-6.70	-10.70	2	13.80	-11.30	11	-6.70	10.70
3	5.00	11.30	12	-4.00	-10.70	3	5.00	-11.30	12	-4.00	10.70
4	2.30	11.30	13	2.30	-10.70	4	2.30	-11.30	13	2.30	10.70
5	-16.80	4.70	14	5.00	-10.70	5	-16.80	-4.70	14	5.00	10.70
6	-16.80	1.70	15	13.80	-10.70	6	-16.80	-1.70	15	13.80	10.70
7	-16.80	-1.30	16	16.80	-10.70	7	-16.80	1.30	16	16.80	10.70
8	-16.80	-4.30	17	16.80	-3.50	8	-16.80	4.30	17	16.80	3.50
9	-16.80	-10.70	18	16.80	3.10	9	-16.80	10.70	18	16.80	-3.10

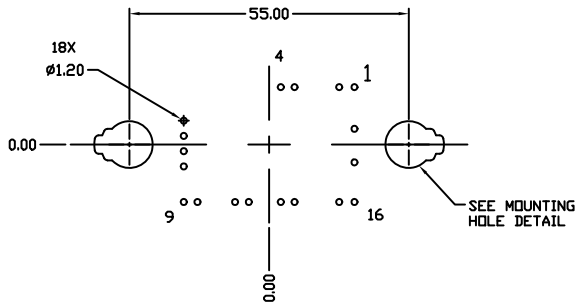
NXH80T120L2Q0S1G

PACKAGE DIMENSIONS

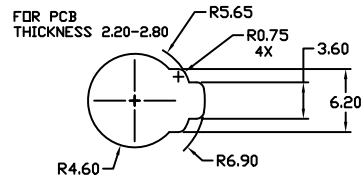
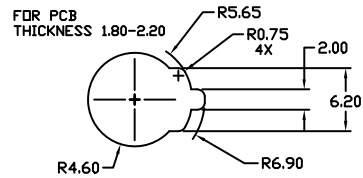
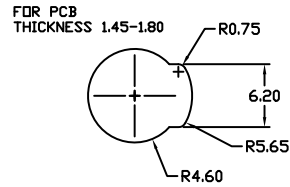
PIM18, 55x32.5 / Q0PACK
CASE 180AH
ISSUE O

MOUNTING HOLE POSITION

PIN	PIN POSITION		PIN	PIN POSITION	
	X	Y		X	Y
1	16.80	11.30	10	-14.10	-10.70
2	13.80	11.30	11	-6.70	-10.70
3	5.00	11.30	12	-4.00	-10.70
4	2.30	11.30	13	2.30	-10.70
5	-16.80	4.70	14	5.00	-10.70
6	-16.80	1.70	15	13.80	-10.70
7	-16.80	-1.30	16	16.80	-10.70
8	-16.80	-4.30	17	16.80	-3.50
9	-16.80	-10.70	18	16.80	3.10



RECOMMENDED
MOUNTING PATTERN



MOUNTING HOLE DETAIL

ON Semiconductor and  are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marketing.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor
19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA
Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada
Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada
Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free
USA/Canada
Europe, Middle East and Africa Technical Support:
Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: <http://www.onsemi.com/orderlit>

For additional information, please contact your local Sales Representative